

**Search Notes**

Application/Control No.

10/622,733

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

LU ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	297	10/6/2006	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) text search - see search history printout	10/6/2006	NT
348/294-299 (text search - see search history printout)	10/9/2006	NT
348/229.1, 294-324, 362 (text search - see search history printout)	10/10/2006	NT
Inventorship search - see search history printout	10/13/2006	NT